

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination NAKAGAWA ET AL.	
			Examiner Louis K. Huynh	Art Unit 3721	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,916,598	11-1975	Adams et al.	53/55
	B	US-4,128,985	12-1978	Simmons, Charles J.	53/502
	C	US-4,546,596	10-1985	Cherney, Dale M.	53/75
	D	US-4,597,240	07-1986	Scully, John W.	53/552
	E	US-4,813,205	03-1989	Mikata et al.	53/502
	F	US-5,241,800	09-1993	Steinke et al.	53/55
	G	US-5,533,322	07-1996	Bacon et al.	53/550
	H	US-5,540,035	07-1996	Plahm et al.	53/550
	I	US-5,822,949	10-1998	Naoi, Mituo	53/55
	J	US-6,233,902	05-2001	Nakagawa, Yukio	53/502
	K	US-6,285,918	09-2001	Kono, Katsuaki	53/502
	L	US-6,460,312	10-2002	Nakagawa et al.	53/502
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04128105 A	04-1992	Japan	SEKO et al.	B65B 09/20
	O	JP 05278729 A	10-1993	Japan	FUKUDA, MASAO	B65B 51/10
	P	JP 07187153 A	07-1995	Japan	FUKUDA, MASAO	B65B 57/02
	Q	JP 10236408 A	09-1998	Japan	FUKUDA, MASAO	B65B 09/20
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages
	U	
	V	
	W	
	X	

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